Applicant(s)/Patent Under Application/Control No. Reexamination 09/945,408 KOHNO ET AL. Notice of References Cited Art Unit Examiner Page 1 of 1 2615 Devona E. Faulk

U.S. PATENT DOCUMENTS

*	1	Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-			
	В	US-			
	С	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	Н	US-			
	ı	US-			
	J	US-			
	к	US-			
	L	US-			
	М	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	JP 10320194 A	12-1998	Japan	TANJI, RYOJI	G06F 9/28
	0					
	Р					
	Q		ļ			
	R					
	s					
	Т					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	w	
	×	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.